

# DS34C87T CMOS Quad TRI-STATE Differential Line Driver

Check for Samples: DS34C87T

#### **FEATURES**

- TTL Input Compatible
- Typical Propagation Delays: 6 ns
- Typical Output Skew: 0.5 ns
- Outputs Won't Load Line When V<sub>CC</sub> = 0V
- Meets the Requirements of EIA Standard RS-422
- Operation from Single 5V Supply
- TRI-STATE Outputs for Connection to System Buses
- Low Quiescent Current
- Available in Surface Mount

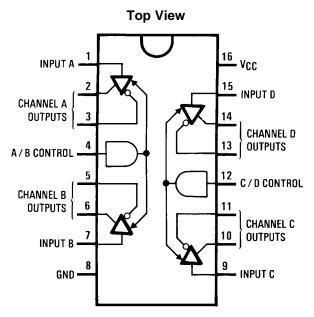
### **DESCRIPTION**

The DS34C87T is a quad differential line driver designed for digital data transmission over balanced lines. The DS34C87T meets all the requirements of EIA standard RS-422 while retaining the low power characteristics of CMOS. This enables the construction of serial and terminal interfaces while maintaining minimal power consumption.

The DS34C87T accepts TTL or CMOS input levels and translates these to RS-422 output levels. This part uses special output circuitry that enables the individual drivers to power down without loading down the bus. This device has separate enable circuitry for each pair of the four drivers. The DS34C87T is pin compatible to the DS3487T.

All inputs are protected against damage due to electrostatic discharge by diodes to V<sub>CC</sub> and ground.

## **Connection and Logic Diagrams**



See PIN DESCRIPTIONS for details.

Figure 1. PDIP Package See Package Numbers D0016A or NFG0016E

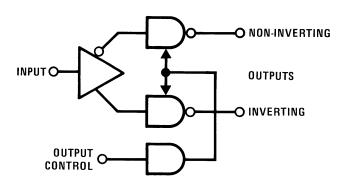


Figure 2. Logic Diagram

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Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



# Truth Table<sup>(1)</sup>

Input	Control	Non-Inverting	Inverting
	Input	Output	Output
Н	Н	Н	L
L	Н	L	Н
Х	L	Z	Z

(1) L = Low logic state

H = High logic state

X = Irrelevant

Z = TRI-STATE (high performance)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# Absolute Maximum Ratings (1)(2)(3)(4)

−0.5 to 7.0V
-1.5 to V <sub>CC</sub> +1.5V
-0.5 to 7V
±20 mA
±150 mA
±150 mA
−65°C to +150°C
•
1736 mW
1226 mW
260°C

- (1) Unless otherwise specified, all voltages are referenced to ground. All currents into device pins are positive; all currents out of device pins are negative.
- (2) Absolute Maximum Ratings are those values beyond which the safety of the device cannot be specified. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provide conditions for actual device operation.
- (3) ESD Rating: HBM (1.5 kΩ, 100 pF) Inputs ≥ 1500V Outputs ≥ 1000V EIAJ (0Ω, 200 pF) All Pins ≥ 350V
- (4) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (5) Ratings apply to ambient temperature at 25°C. Above this temperature derate NFG0016E Package 13.89 mW/°C, and D0016A Package 9.80 mW/°C.
- (6) ESD Rating: HBM (1.5 k $\Omega$ , 100 pF) Inputs ≥ 1500V Outputs ≥ 1000V EIAJ (0 $\Omega$ , 200 pF) All Pins ≥ 350V

## **Operating Conditions**

	Min	Max	Units
Supply Voltage (V <sub>CC</sub> )	4.50	5.50	V
DC Input or Output Voltage (V <sub>IN</sub> , V <sub>OUT</sub> )	0	V <sub>CC</sub>	V
Operating Temperature Range (T <sub>A</sub> ) DS34C87T	-40	+85	°C
Input Rise or Fall Times (t <sub>r</sub> , t <sub>f</sub> )		500	ns



## DC Electrical Characteristics(1)

 $V_{CC} = 5V \pm 10\%$  (unless otherwise specified)

	Parameter	Test Conditions	Min	Тур	Max	Units
V <sub>IH</sub> High Level Input			2.0			V
	Voltage					
V <sub>IL</sub>	Low Level Input				0.8	V
	Voltage					
V <sub>OH</sub>	High Level Output	$V_{IN} = V_{IH}$ or $V_{IL}$ ,	2.5	3.4		V
	Voltage	I <sub>OUT</sub> = −20 mA				
V <sub>OL</sub>	Low Level Output	$V_{IN} = V_{IH}$ or $V_{IL}$ ,		0.3	0.5	V
	Voltage	I <sub>OUT</sub> = 48 mA				
V <sub>T</sub>	Differential Output	R <sub>L</sub> = 100 Ω	2.0	3.1		V
	Voltage	See <sup>(2)</sup>				
$ V_T - \overline{V}_T $	Difference In	R <sub>L</sub> = 100 Ω			0.4	V
	Differential Output	See <sup>(2)</sup>				
Vos	Common Mode	R <sub>L</sub> = 100 Ω		2.0	3.0	V
	Output Voltage	See <sup>(2)</sup>				
Vos-Vos	Difference In	R <sub>L</sub> = 100 Ω			0.4	V
	Common Mode Output	See <sup>(2)</sup>				
I <sub>IN</sub>	Input Current	$V_{IN} = V_{CC}$ , GND, $V_{IH}$ , or $V_{IL}$			±1.0	μΑ
Icc	Quiescent Supply	I <sub>OUT</sub> = 0 μA,				
	Current	$V_{IN} = V_{CC}$ or GND		200	500	μΑ
		$V_{IN} = 2.4V \text{ or } 0.5V^{(3)}$		0.8	2.0	mA
l <sub>OZ</sub>	TRI-STATE Output	V <sub>OUT</sub> = V <sub>CC</sub> or GND		±0.5	±5.0	μA
	Leakage Current	Control = V <sub>IL</sub>				
I <sub>SC</sub> Output Short		V <sub>IN</sub> = V <sub>CC</sub> or GND	-30		-150	mA
	Circuit Current	See <sup>(2)</sup> and <sup>(4)</sup>				
I <sub>OFF</sub>	Power Off Output	V <sub>CC</sub> = 0V V <sub>OUT</sub> = 6V			100	μA
	Leakage Current	See <sup>(2)</sup> $V_{OUT} = -0.25V$			-100	μΑ

Unless otherwise specified, min/max limits apply across the -40°C to 85°C temperature range. All typicals are given for V<sub>CC</sub> = 5V and T<sub>A</sub> = 25°C.
 See EIA Specification RS-422 for exact test conditions.
 Measured per input. All other inputs at V<sub>CC</sub> or GND.
 This is the current sourced when a high output is shorted to ground. Only one output at a time should be shorted.



# Switching Characteristics(1)

 $V_{CC} = 5V \pm 10\%$ , t<sub>r</sub>, t<sub>f</sub>  $\leq$  6 ns (Figure 3, Figure 4, Figure 5, Figure 6)

	Parameter	Test Conditions	Min	Тур	Max	Units
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Input to Output	S1 Open		6	11	ns
Skew	See <sup>(2)</sup>	S1 Open		0.5	3	ns
t <sub>TLH</sub> , t <sub>THL</sub>	Differential Output Rise And Fall Times	S1 Open		6	10	ns
t <sub>PZH</sub>	Output Enable Time	S1 Closed		12	25	ns
t <sub>PZL</sub>	Output Enable Time	S1 Closed		13	26	ns
t <sub>PHZ</sub>	Output Disable Time <sup>(3)</sup>	S1 Closed		4	8	ns
t <sub>PLZ</sub>	Output Disable Time <sup>(3)</sup>	S1 Closed		6	12	ns
C <sub>PD</sub>	Power Dissipation Capacitance <sup>(4)</sup>			100		pF
C <sub>IN</sub>	Input Capacitance			6		pF

- (1) Unless otherwise specified, min/max limits apply across the  $-40^{\circ}$ C to 85°C temperature range. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.
- (2) Skew is defined as the difference in propagation delays between complementary outputs at the 50% point.
- (3) Output disable time is the delay from the control input being switched to the output transistors turning off. The actual disable times are less than indicated due to the delay added by the RC time constant of the load.
- (4) C<sub>PD</sub> determines the no load dynamic power consumption, P<sub>D</sub> = C<sub>PD</sub> V<sup>2</sup>CC f + I<sub>CC</sub> V<sub>CC</sub>, and the no load dynamic current consumption, I<sub>S</sub> = C<sub>PD</sub> V<sub>CC</sub> f + I<sub>CC</sub>.

# Comparison Table of Switching Characteristics into "LS-Type" Load (1)

 $V_{CC}$  = 5V,  $T_A$  = +25°C,  $t_r \le 6$  ns,  $t_f \le 6$  ns (Figure 6, Figure 7, Figure 8, Figure 9, Figure 10, Figure 11)

	Barranatan	To al O an altitura	DS3	4C87	DS	Unito	
	Parameter Test Conditions		Тур	Max	Тур	Max	Units
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay		6	10	10	15	ns
	Input to Output						
Skew	See <sup>(2)</sup>		1.5	2.0			ns
t <sub>THL</sub> , t <sub>TLH</sub>	Differential Output Rise		4	7	10	15	ns
	and Fall Times						
t <sub>PHZ</sub>	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	8	11	17	25	ns
	See <sup>(3)</sup>	S1 Closed, S2 Closed					
t <sub>PLZ</sub>	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	7	10	15	25	ns
	See <sup>(3)</sup>	S1 Closed, S2 Closed					
t <sub>PZH</sub>	Output Enable Time	$C_L = 50 \text{ pF}, R_L = \infty,$	11	19	11	25	ns
		S1 Open, S2 Closed					
t <sub>PZL</sub>	Output Enable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	14	21	15	25	ns
		S1 Closed, S2 Open					

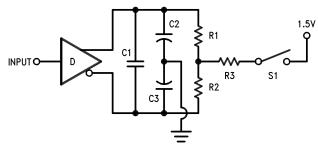
<sup>(1)</sup> This table is provided for comparison purposes only. The values in this table for the DS34C87 reflect the performance of the device but are not tested or ensured.

<sup>(2)</sup> Skew is defined as the difference in propagation delays between complementary outputs at the 50% point.

<sup>(3)</sup> Output disable time is the delay from the control input being switched to the output transistors turning off. The actual disable times are less than indicated due to the delay added by the RC time constant of the load.



#### AC TEST CIRCUIT AND SWITCHING TIME WAVEFORMS



Note: C1 = C2 = C3 = 40 pF (including Probe and Jig Capacitance), R1 = R2 =  $50\Omega$ , R3 =  $500\Omega$ 

Figure 3. AC Test Circuit

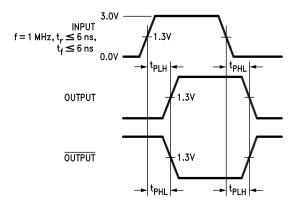


Figure 4. Propagation Delays

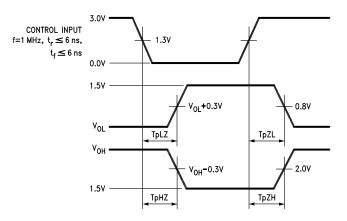


Figure 5. Enable and Disable Times

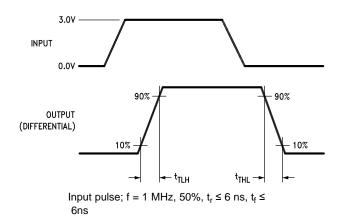


Figure 6. Differential Rise and Fall Times

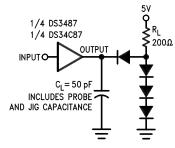


Figure 7. Propagation Delays Test Circuit for "LS-Type" Load



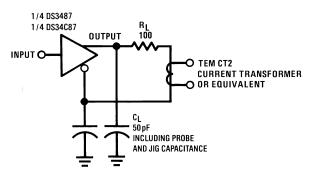


Figure 8. Differential Rise and Fall Times Test Circuit for "LS-Type" Load

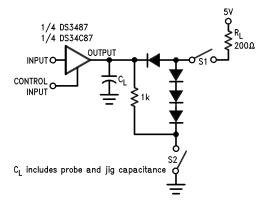


Figure 9. Load Enable and Disable Times Test Circuit for "LS-Type" Load

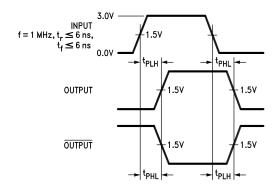


Figure 10. Load Propagation Delays for "LS-Type" Load

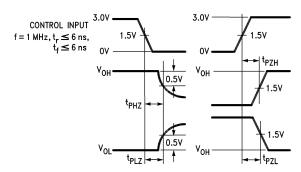
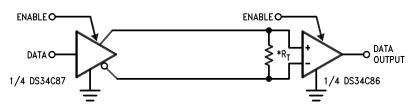


Figure 11. Load Enable and Disable Times for "LS-Type" Load

#### TYPICAL APPLICATIONS



\*R<sub>T</sub> is optional although highly recommended to reduce reflection.

Submit Documentation Feedback



### PIN DESCRIPTIONS

Pin Number (PDIP or SOIC package)	Pin Name	Function	
1	INPUT A	Channel A - TTL/CMOS input	
2	OUTPUT A - True	True Output for Channel A, RS422 Levels	
3	OUTPUT A - Inverting	Inverting Output for Channel A, RS422 Levels	
4	A/B CONTROL	Enable Pin for Channels A and B, Active High, TTL/CMOS Levels	
5	OUTPUT B - Inverting	Inverting Output for Channel B, RS422 Levels	
6	OUTPUT B - True	True Output for Channel B, RS422 Levels	
7	INPUT B	Channel B - TTL/CMOS input	
8	GND	Ground Pin (0 V)	
9	INPUT C	Channel C - TTL/CMOS input	
10	OUTPUT C - True	True Output for Channel C, RS422 Levels	
11	OUTPUT C - Inverting	Inverting Output for Channel C, RS422 Levels	
12	C/D CONTROL	Enable Pin for Channels C and D, Active High, TTL/CMOS Levels	
13	OUTPUT D - Inverting	Inverting Output for Channel D, RS422 Levels	
14	OUTPUT D - True	True Output for Channel D, RS422 Levels	
15	INPUT D	Channel D - TTL/CMOS input	
16	V <sub>CC</sub>	Power Supply Pin, 5.0V typical	

## SNLS376B -MAY 1998-REVISED APRIL 2013



# **REVISION HISTORY**

Cł	hanges from Revision A (April 2013) to Revision B	Page
•	Changed layout of National Data Sheet to TI format	





9-Mar-2016

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
DS34C87TM	NRND	SOIC	D	16	48	TBD	Call TI	Call TI	-40 to 85	DS34C87TM	
DS34C87TM/NOPB	ACTIVE	SOIC	D	16	48	Green (RoHS & no Sb/Br)	CU SN   Call TI	Level-1-260C-UNLIM	-40 to 85	DS34C87TM	Samples
DS34C87TMX	NRND	SOIC	D	16	2500	TBD	Call TI	Call TI	-40 to 85	DS34C87TM	
DS34C87TMX/NOPB	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	DS34C87TM	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free** (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free** (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE OPTION ADDENDUM**

9-Mar-2016

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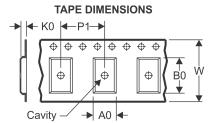
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# PACKAGE MATERIALS INFORMATION

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# TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

## QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS34C87TMX	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1
DS34C87TMX/NOPB	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1

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#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS34C87TMX	SOIC	D	16	2500	367.0	367.0	35.0
DS34C87TMX/NOPB	SOIC	D	16	2500	367.0	367.0	35.0

# D (R-PDS0-G16)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



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